

MOSFET – Dual, N-Channel, POWERTRENCH®

30 V, 2.9 A, 123 mΩ

FDMA2002NZ

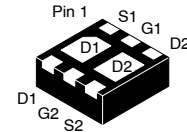
General Description

This device is designed specifically as a single package solution for dual switching requirements in cellular handset and other ultra-portable applications. It features two independent N-Channel MOSFETs with low on-state resistance for minimum conduction losses. The MicroFET™ 2x2 offers exceptional thermal performance for its physical size and is well suited to linear mode applications.

Features

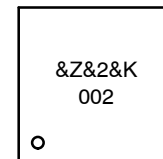
- 2.9 A, 30 V
 $R_{DS(on)} = 123 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$
 $R_{DS(on)} = 140 \text{ m}\Omega$ at $V_{GS} = 3.0 \text{ V}$
 $R_{DS(on)} = 163 \text{ m}\Omega$ at $V_{GS} = 2.5 \text{ V}$
- Low Profile – 0.8 mm Maximum – In the New Package MicroFET 2x2 mm
- HBM ESD Protection Level > 1.8 kV (Note 3)
- Free from Halogenated Compounds and Antimony Oxides
- This Device is Pb-Free, Halide Free and is RoHS Compliant

V_{DS}	$R_{DS(on)}$ MAX	I_D MAX
30 V	123 mΩ @ 4.5 V	2.9 A
	140 mΩ @ 3.0 V	
	163 mΩ @ 2.5 V	



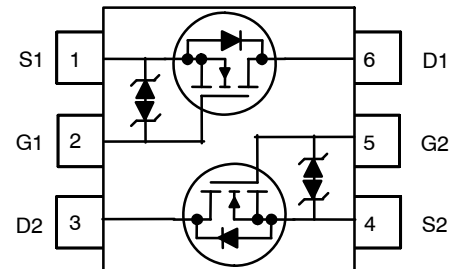
**WDFN6 2x2, 0.65P
(MicroFET 2x2)
CASE 511DA**

MARKING DIAGRAM



&Z = Assembly Plant Code
&2 = 2-Digit Date Code
&K = 2-Digits Lot Run Traceability Code
002 = Device Code

PIN CONNECTIONS



ORDERING INFORMATION

Device	Package	Shipping†
FDMA2002NZ	WDFN6 (Pb-Free, Halide Free)	3000 / Tape & Reel

For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, [BRD8011/D](#).

FDMA2002NZ

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
V _{DS}	Drain–Source Voltage	30	V
V _{GS}	Gate–Source Voltage	±12	V
I _D	Drain Current –Continuous (T _C = 25°C, V _{GS} = 4.5 V) –Continuous (T _C = 25°C, V _{GS} = 2.5 V)	2.9 2.7	A
	–Pulsed	10	A
P _D	Power Dissipation for Single Operation (Note 1a) (Note 1b)	1.5 0.65	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
R _{θJA}	Thermal Resistance, Junction to Ambient (Note 1a)	83 (Single Operation)	°C/W
R _{θJA}	Thermal Resistance, Junction to Ambient (Note 1b)	193 (Single Operation)	
R _{θJA}	Thermal Resistance, Junction to Ambient (Note 1c)	68 (Dual Operation)	
R _{θJA}	Thermal Resistance, Junction to Ambient (Note 1d)	145 (Dual Operation)	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

BV _{DSS}	Drain–Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	30	–	–	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	–	25	–	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V	–	–	1	μA
I _{GSS}	Gate–Body Leakage	V _{GS} = ±12 V, V _{DS} = 0 V	–	–	±10	μA

ON CHARACTERISTICS

V _{GS(th)}	Gate Threshold Voltage	I _D = 250 μA, V _{DS} = V _{GS}	0.4	1.0	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	–	–3	–	mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	V _{GS} = 4.5 V, I _D = 2.9 A	–	75	123	mΩ
		V _{GS} = 3.0 V, I _D = 2.7 A	–	84	140	
		V _{GS} = 2.5 V, I _D = 2.5 A	–	92	163	
		V _{GS} = 4.5 V, I _D = 2.9 A, T _C = 85°C	–	95	166	
		V _{GS} = 3.0 V, I _D = 2.7 A, T _C = 150°C	–	138	203	
		V _{GS} = 2.5 V, I _D = 2.5 A, T _C = 150°C	–	150	268	

DYNAMIC CHARACTERISTICS

C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	–	190	220	pF
C _{oss}	Output Capacitance		–	30	40	pF
C _{rss}	Reverse Transfer Capacitance		–	20	30	pF

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

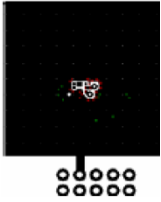
Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
SWITCHING CHARACTERISTICS (Note 2)						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 15\text{ V}$, $I_D = 1\text{ A}$ $V_{GS} = 4.5\text{ V}$, $R_{GEN} = 6\ \Omega$	–	6	12	ns
t_r	Turn-On Rise Time		–	8	16	ns
$t_{d(off)}$	Turn-Off Delay Time		–	12	21	ns
t_f	Turn-Off Fall Time		–	2	10	ns
Q_g	Total Gate Charge	$V_{DS} = 15\text{ V}$, $I_D = 2.9\text{ A}$, $V_{GS} = 4.5\text{ V}$	–	2.4	3.0	nC
Q_{gs}	Gate–Source Charge		–	0.35	–	nC
Q_{gd}	Gate–Drain Charge		–	0.75	–	nC

DRAIN–SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

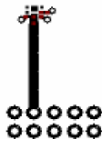
I_S	Maximum Continuous Source–Drain Diode Forward Current		–	–	2.9	A
V_{SD}	Source–Drain Diode Forward Voltage	$I_S = 2.0\text{ A}$	–	0.9	1.2	V
		$I_S = 1.1\text{ A}$	–	0.8	1.2	
t_{rr}	Diode Reverse Recovery Time	$I_F = 2.9\text{ A}$, $dI_F/dt = 100\text{ A}/\mu\text{s}$	–	10	–	ns
Q_{rr}	Diode Reverse Recovery Charge		–	2	–	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- $R_{\theta JA}$ is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.
 - $R_{\theta JA} = 83^\circ\text{C}/\text{W}$ when mounted on a 1 in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB. For single operation.
 - $R_{\theta JA} = 193^\circ\text{C}/\text{W}$ when mounted on a minimum pad of 2 oz copper.. For single operation.
 - $R_{\theta JA} = 68^\circ\text{C}/\text{W}$ when mounted on a 1 in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB. For dual operation.
 - $R_{\theta JA} = 145^\circ\text{C}/\text{W}$ when mounted on a minimum pad of 2 oz copper. For dual operation.



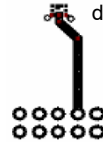
a. $83^\circ\text{C}/\text{W}$ when mounted on a 1 in² pad of 2 oz copper.



b. $193^\circ\text{C}/\text{W}$ when mounted on a minimum pad of 2 oz copper.



c. $68^\circ\text{C}/\text{W}$ when mounted on a 1 in² pad of 2 oz copper.



d. $145^\circ\text{C}/\text{W}$ when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs , Duty Cycle < 2.0%
- The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

TYPICAL CHARACTERISTICS

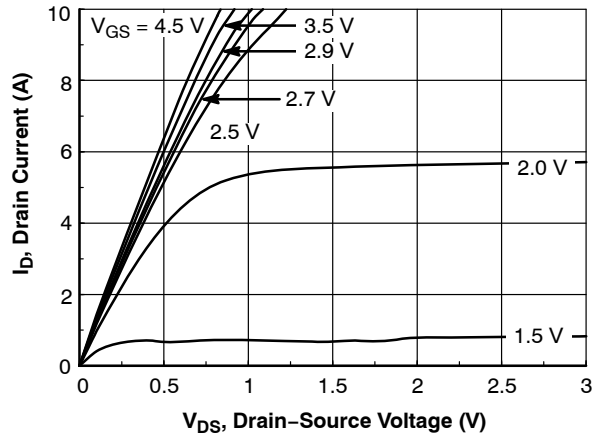


Figure 1. On-Region Characteristics

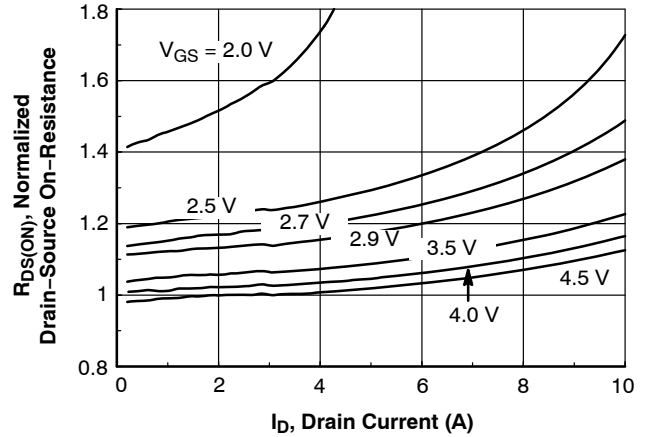


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

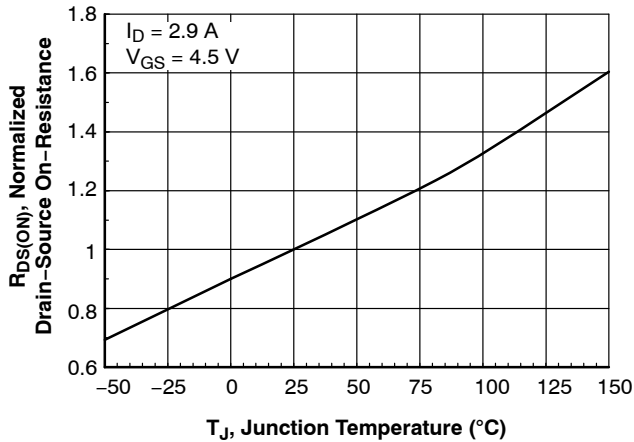


Figure 3. On-Resistance Variation with Temperature

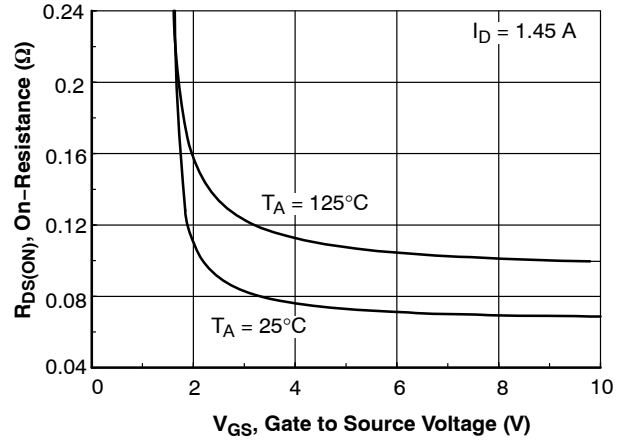


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

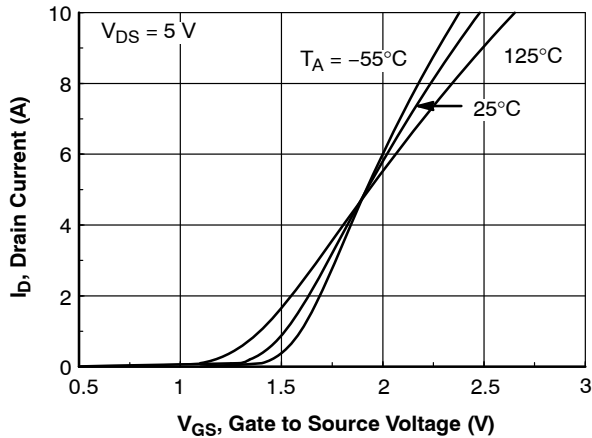


Figure 5. Transfer Characteristics

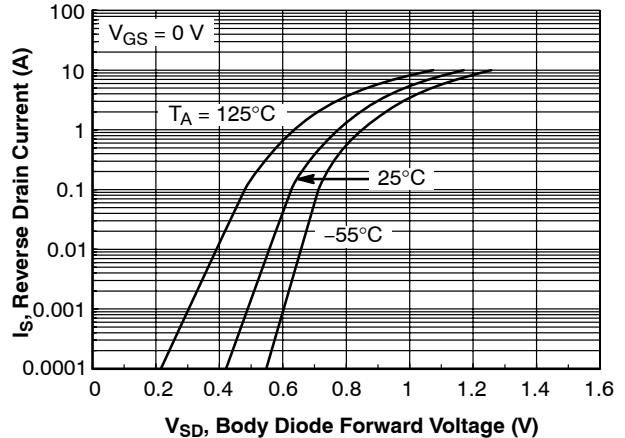


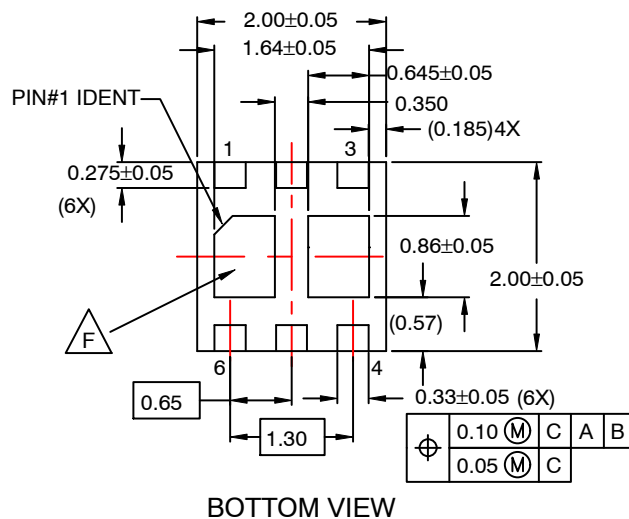
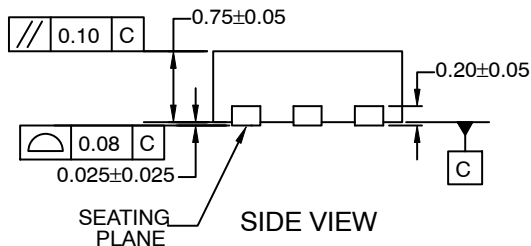
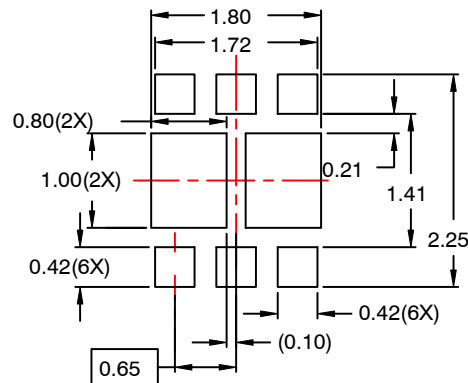
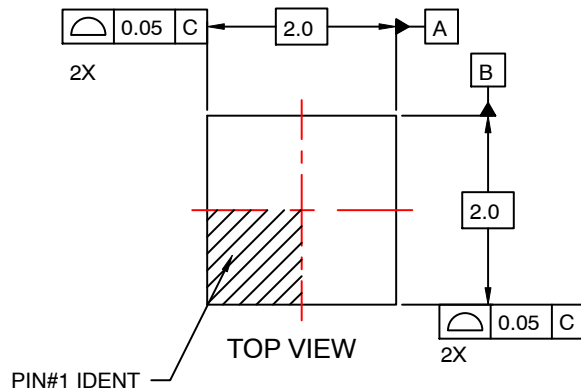
Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

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WDFN6 2x2, 0.65P CASE 511DA ISSUE O

DATE 31 JUL 2016



NOTES:

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- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

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